

# MOSFET – N-Channel, Shielded Gate POWERTRENCH®

80 V, 51 A, 10 mΩ

## FDMC010N08C

### General Description

This N-Channel MV MOSFET is produced using onsemi's advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized to minimise on-state resistance and yet maintain superior switching performance with best in class soft body diode.

### Features

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)}$  = 10 mΩ at  $V_{GS} = 10$  V,  $I_D = 16$  A
- Max  $R_{DS(on)}$  = 25 mΩ at  $V_{GS} = 6$  V,  $I_D = 8$  A
- 50% Lower  $Q_{rr}$  than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

### Application

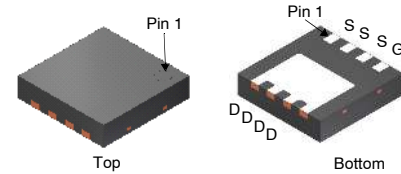
- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar

### MOSFET MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	80	V
$V_{GS}$	Gate to Source Voltage	±20	V
$I_D$	Drain Current		A
	- Continuous	$T_C = 25^\circ\text{C}$ (Note 5)	51
	- Continuous	$T_C = 100^\circ\text{C}$ (Note 5)	32
	- Continuous	$T_A = 25^\circ\text{C}$ (Note 1a)	11
	- Pulsed	(Note 4)	206
EAS	Single Pulse Avalanche Energy (Note 3)	96	mJ
$P_D$	Power Dissipation	$T_C = 25^\circ\text{C}$	52
	Power Dissipation	$T_A = 25^\circ\text{C}$ (Note 1a)	2.4
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

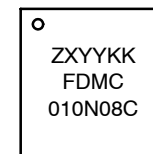
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

$V_{DS}$	$R_{DS(on)}$ MAX	$I_D$ MAX
80 V	10 mΩ @ 10 V	51 A
	25 mΩ @ 6 V	



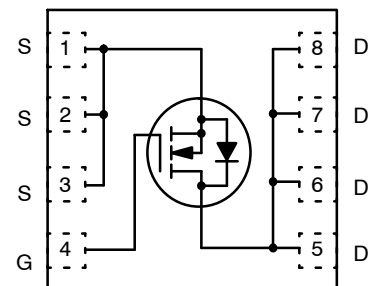
WDFN8 3.3x3.3, 0.65P  
(Power 33)  
CASE 483AW

### MARKING DIAGRAM



- Z = Assembly Plant Code
- X = Numeric Year Code
- YY = Weekly Date Code
- KK = Numeric Lot Code
- FDMC010N08C = Specific Device Code

### PIN ASSIGNMENT



N-Channel MOSFET

### ORDERING INFORMATION

Device	Package	Shipping†
FDMC010N08C	WDFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](#).

# FDMC010N08C

## THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	°C/W

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
$\Delta BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}$ , $V_{GS} = 0 \text{ V}$	80	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , referenced to $25^\circ\text{C}$	-	75	-	mV/°C
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	-	1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	-	-	$\pm 100$	nA

## ON CHARACTERISTICS

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 90 \mu\text{A}$	2.0	2.9	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 90 \mu\text{A}$ , referenced to $25^\circ\text{C}$	-	-8	-	mV/°C
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 16 \text{ A}$	-	8.0	10	m $\Omega$
		$V_{GS} = 6 \text{ V}$ , $I_D = 8 \text{ A}$	-	12.3	25	
		$V_{GS} = 10 \text{ V}$ , $I_D = 16 \text{ A}$ , $T_J = 125^\circ\text{C}$	-	14	18	
$g_{FS}$	Forward Transconductance	$V_{DS} = 5 \text{ V}$ , $I_D = 16 \text{ A}$	-	35	-	S

## DYNAMIC CHARACTERISTICS

$C_{iss}$	Input Capacitance	$V_{DS} = 40 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	-	1070	1500	pF
$C_{oss}$	Output Capacitance		-	381	530	pF
$C_{riss}$	Reverse Transfer Capacitance		-	20	30	pF
$R_g$	Gate Resistance		0.1	0.4	0.7	$\Omega$

## SWITCHING CHARACTERISTICS

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 40 \text{ V}$ , $I_D = 16 \text{ A}$ , $V_{GS} = 10 \text{ V}$ , $R_{GEN} = 6 \Omega$	-	9	19	ns	
$t_r$	Rise Time		-	3	10	ns	
$t_{d(off)}$	Turn-Off Delay Time		-	17	31	ns	
$t_f$	Fall Time		-	5	10	ns	
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ V}$ to $10 \text{ V}$	$V_{DD} = 40 \text{ V}$ , $I_D = 16 \text{ A}$	-	15	22	nC
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ V}$ to $6 \text{ V}$		-	10	14	nC
$Q_{gs}$	Gate to Source Charge	$V_{DD} = 40 \text{ V}$ $I_D = 16 \text{ A}$	-	5	-	nC	
$Q_{gd}$	Gate to Drain "Miller" Charge	$V_{DD} = 40 \text{ V}$ $I_D = 16 \text{ A}$	-	3	-	nC	
$Q_{oss}$	Output Charge	$V_{DD} = 40 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	22.1	-	nC	
$Q_{sync}$	Total Gate Charge Sync	$V_{DS} = 0 \text{ V}$ , $I_D = 16 \text{ A}$	-	13.3	-	nC	

## DRAIN-SOURCE DIODE CHARACTERISTICS

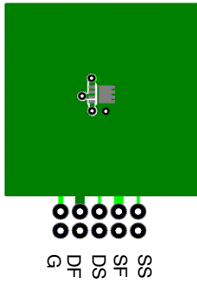
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_S = 2 \text{ A}$ (Note 2)	-	0.7	1.2	V
		$V_{GS} = 0 \text{ V}$ , $I_S = 16 \text{ A}$ (Note 2)	-	0.8	1.3	
$t_{rr}$	Reverse Recovery Time	$I_F = 8 \text{ A}$ , $di/dt = 300 \text{ A}/\mu\text{s}$	-	17	30	ns
$Q_{rr}$	Reverse Recovery Charge		-	20	33	nC
$t_{rr}$	Reverse Recovery Time	$I_F = 8 \text{ A}$ , $di/dt = 1000 \text{ A}/\mu\text{s}$	-	13	23	ns
$Q_{rr}$	Reverse Recovery Charge		-	45	73	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

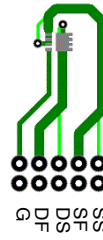
# FDMC010N08C

## NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0 %.
3.  $E_{AS}$  of 96 mJ is based on starting  $T_J = 25$  °C,  $L = 3$  mH,  $I_{AS} = 8$  A,  $V_{DD} = 72$  V,  $V_{GS} = 10$  V. 100% test at  $L = 0.1$  mH,  $I_{AS} = 25$  A.
4. Pulsed  $I_d$  please refer to Fig 11 SOA graph for more details.
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

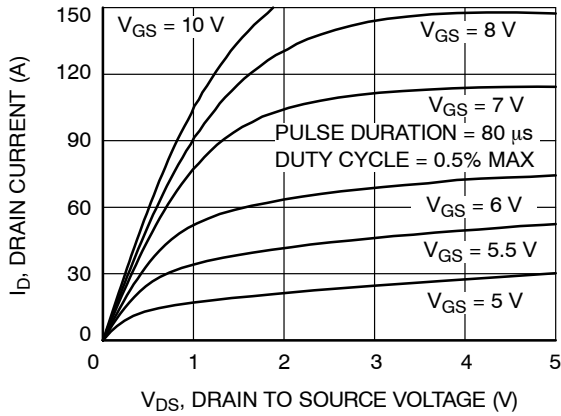


Figure 1. On-Region Characteristics

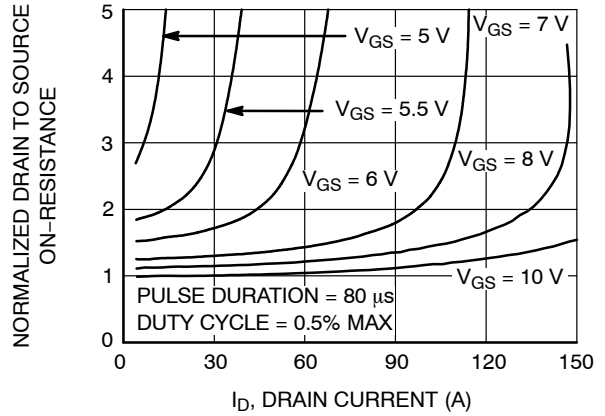


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

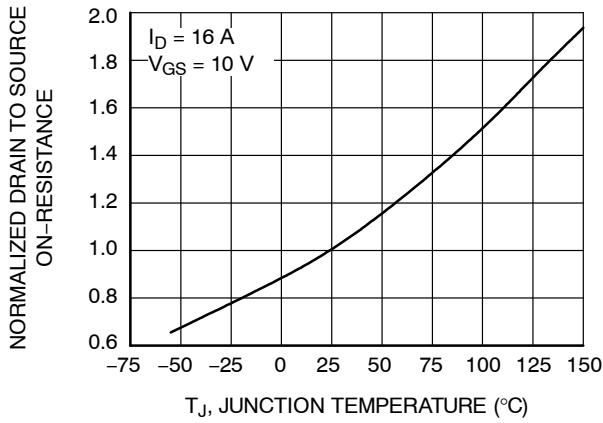


Figure 3. Normalized On Resistance vs. Junction Temperature

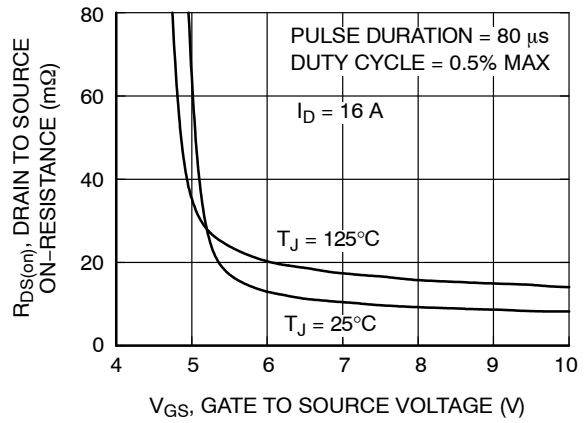


Figure 4. On-Resistance vs. Gate to Source Voltage

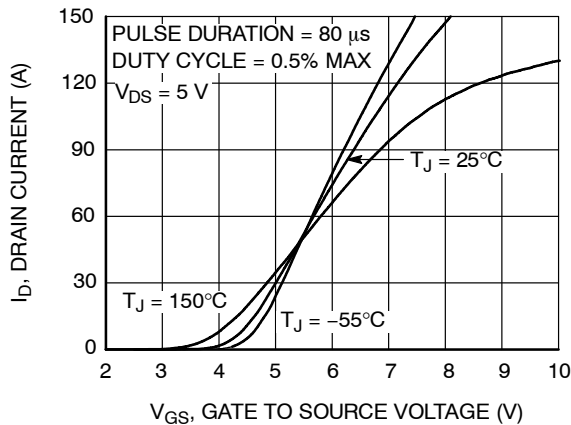


Figure 5. Transfer Characteristics

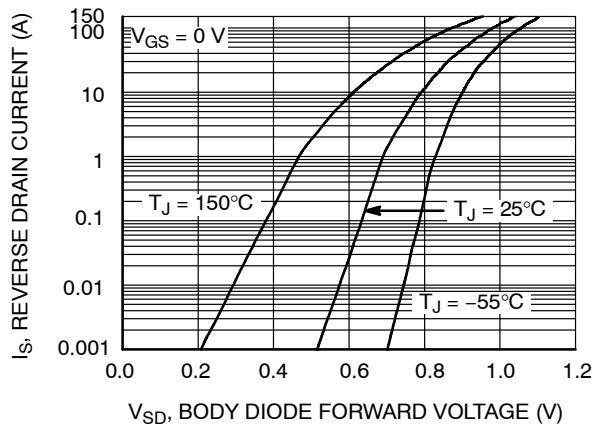


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$  unless otherwise noted) (continued)

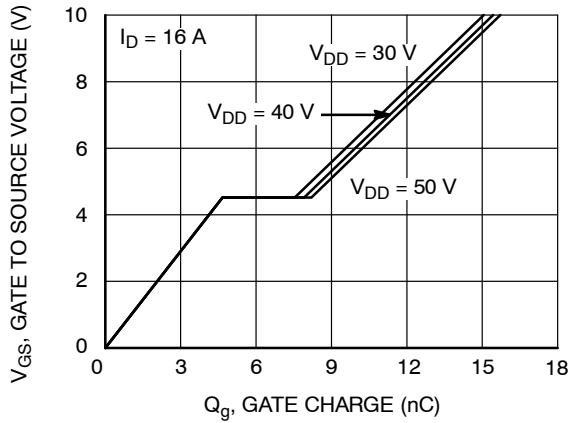


Figure 7. Gate Charge Characteristics

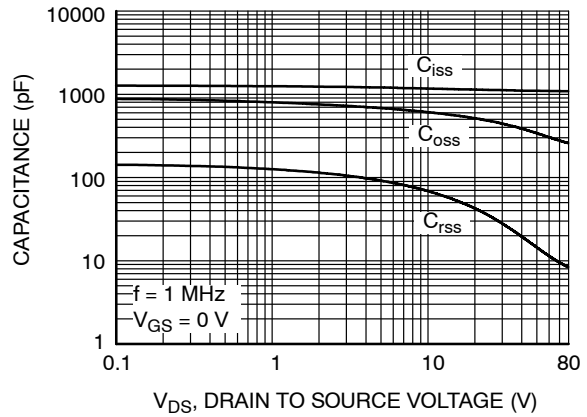


Figure 8. Capacitance vs. Drain to Source Voltage

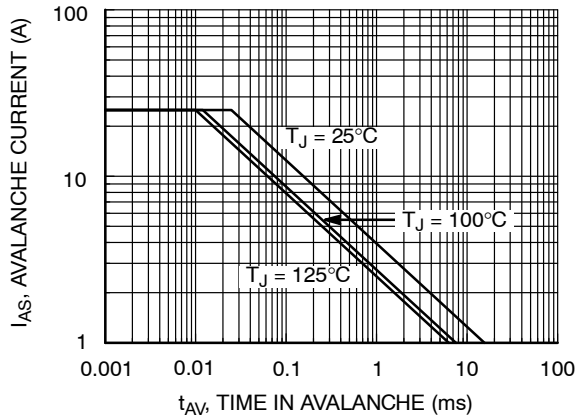


Figure 9. Unclamped Inductive Switching Capability

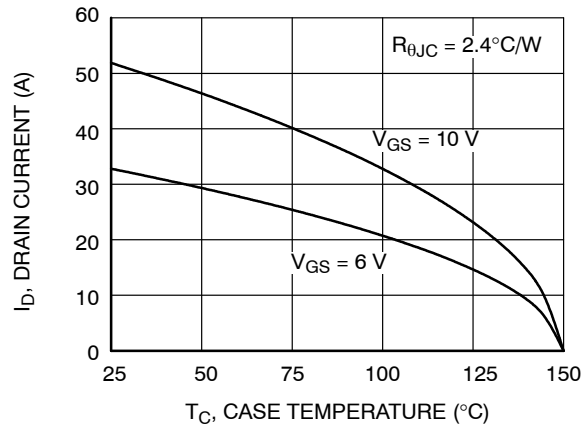


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

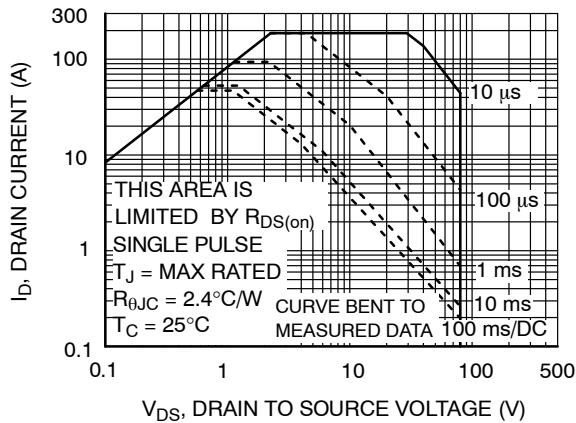


Figure 11. Forward Bias Safe Operating Area

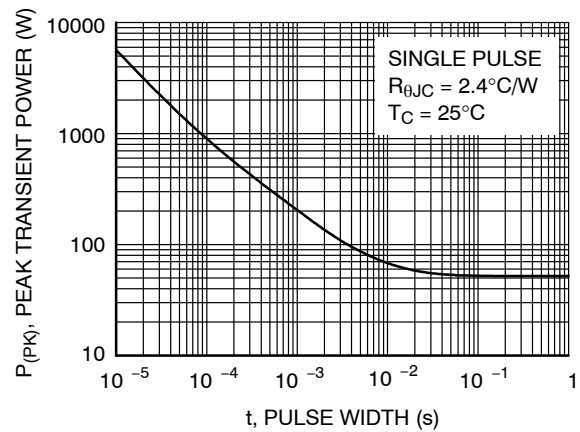


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$  unless otherwise noted) (continued)

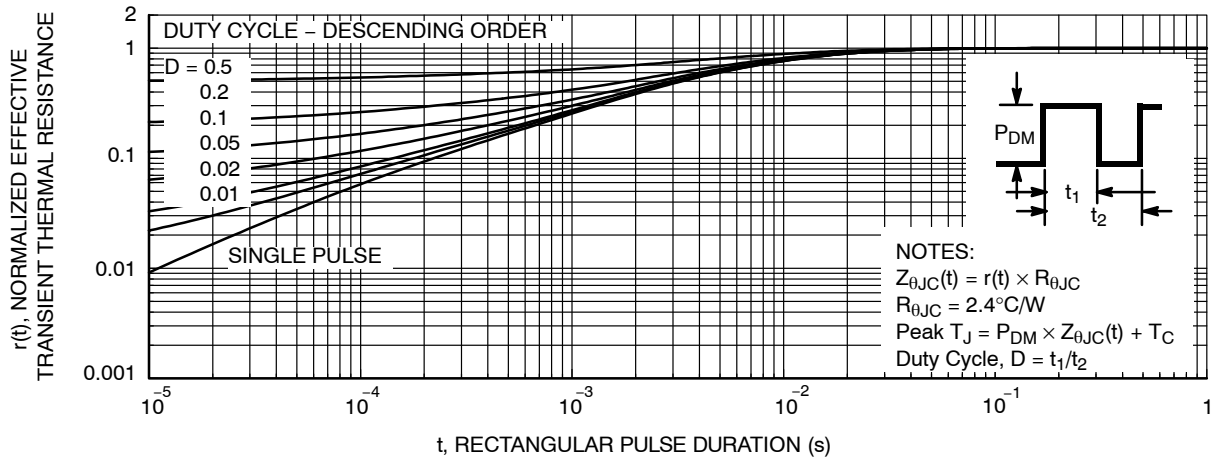


Figure 13. Junction-to-Case Transient Thermal Response Curve

# MECHANICAL CASE OUTLINE

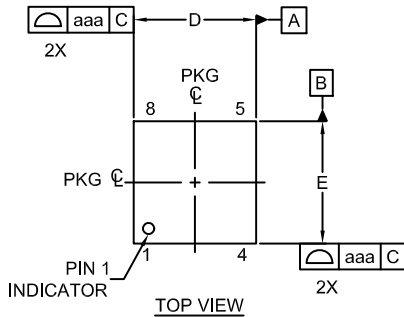
## PACKAGE DIMENSIONS

ON Semiconductor®

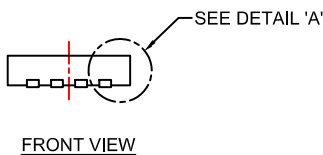


**WDFN8 3.3X3.3, 0.65P**  
**CASE 483AW**  
**ISSUE A**

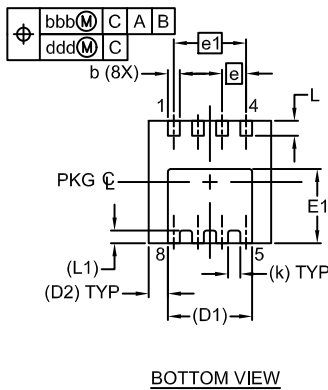
DATE 10 SEP 2019



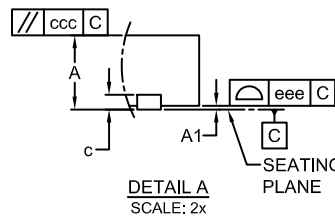
TOP VIEW



FRONT VIEW

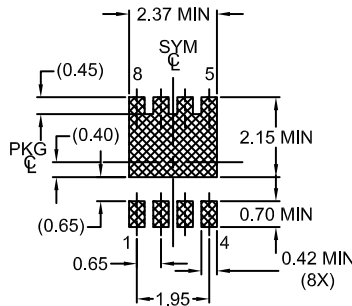


BOTTOM VIEW



DETAIL A  
SCALE: 2x

### LAND PATTERN RECOMMENDATION\*



### NOTES:

1. CONTROLLING DIMENSION: MILLIMETERS.
2. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
4. SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	-	-	0.05
b	0.27	0.32	0.37
c	0.15	0.20	0.25
D	3.20	3.30	3.40
D1	2.27 REF		
D2	0.52 REF		
E	3.20	3.30	3.40
E1	1.85	1.95	2.05
e	0.65 BSC		
e1	1.95 BSC		
k	0.33 REF		
L	0.30	0.40	0.50
L1	0.34 REF		
aaa	0.10		
bbb	0.10		
ccc	0.10		
ddd	0.05		
eee	0.05		

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

### GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code  
 A = Assembly Location  
 Y = Year  
 WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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